

TRL Calibration Issues and Improvements

Tom Dagostino

tom@teraspeed.com

Teraspeed Labs
Teraspeed Consulting Group LLC

DesignCon 2010 TF-MA12 Tutorial
Feb. 1, 2010



Typical Measurement Objective

- Measure S-parameters of a very specific structure, on a PCB, for creating a model of the device



Want a Model Directly from Measurements

- After calibration we would like to be able to use measurements as a model
 - No post processing of data
 - No causality or passivity issues for passive structures
 - No fixes
 - No fuss, no bother



TRL Calibration for Dummies

- TRL does not require accurately modeled cal kit elements (relative to SOLT)
- TRL is a good solution for moving reference planes up to DUT on PCB's with no expensive calibration substrates or carefully modeled structures (SOLT)
- What is Required:
 - Launch must have superb S.I. (low SI I, no resonance)
 - Connector repeatability from SMA to SMA – TDR confirm
 - Line lengths accurate – layout, etch
 - Impedance variation across board low – etch, fiber weave, etc.,



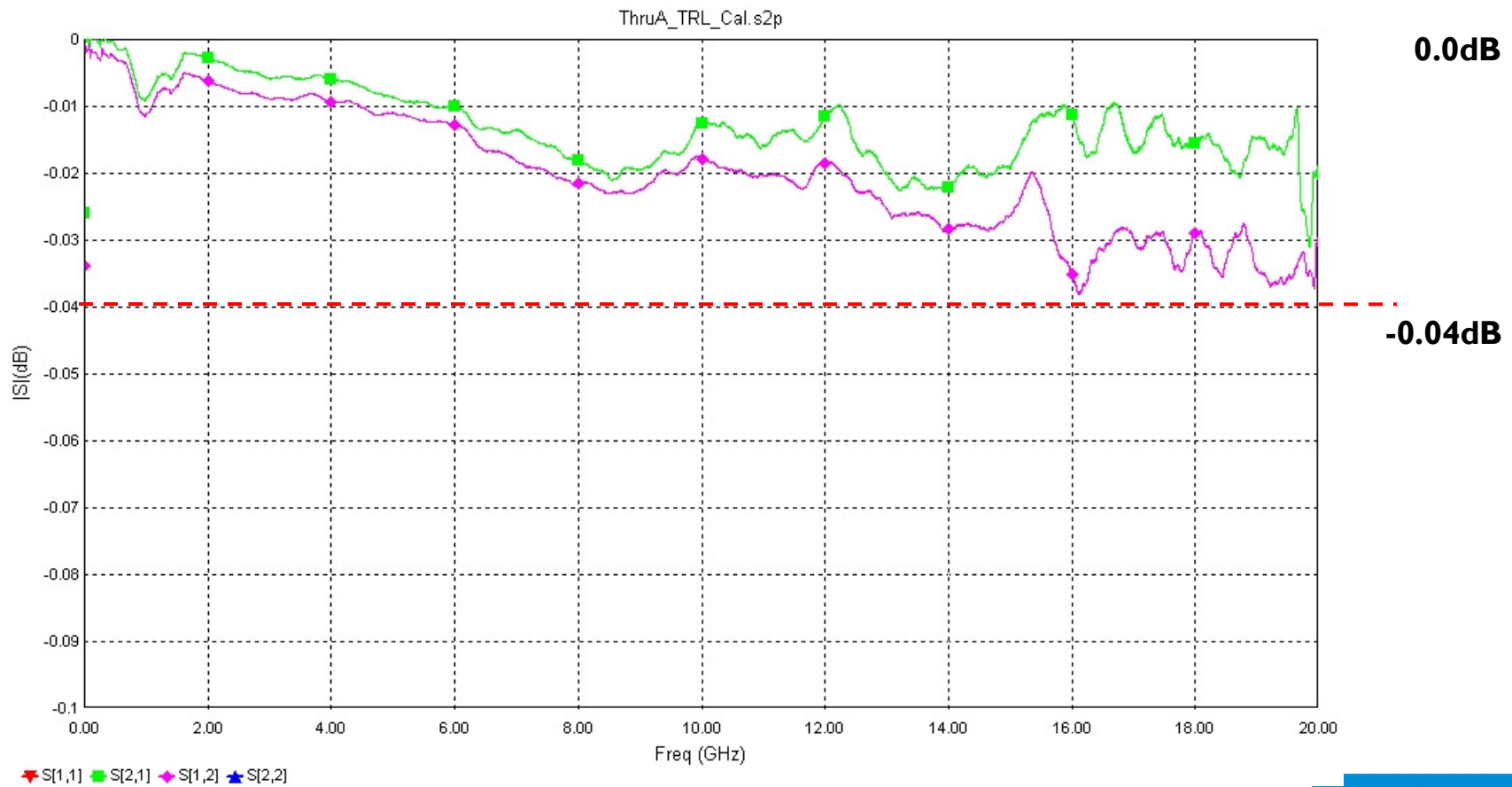
Ideal Measurement of THRU after Calibration

- Insertion loss should equal zero
- Should be passive
 - No gain from a passive structure
 - Cannot create energy
- Return loss should be very low
- Should be causal
 - Output should not occur before input



**TERASPEED
CONSULTING
GROUP**

Thru A TRL S2I detail, 0.04dB error to 20GHz

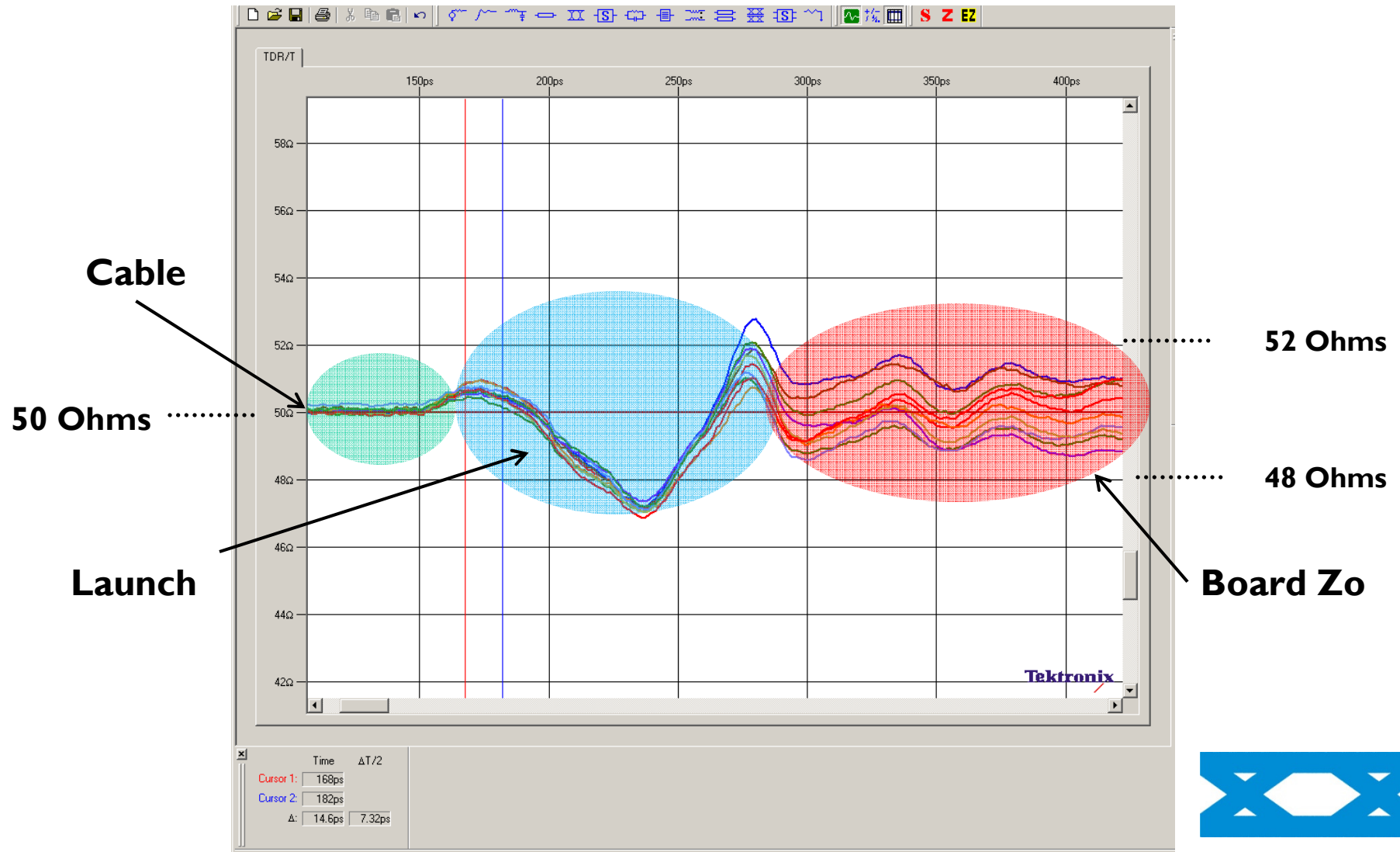


What makes a good TRL calibration kit design?

- Consistent RF Launches
- Consistent Line impedance



Goal is Consistent Z_0 through system



Impedance Profiles THRU, LINE1,2,3 variation approximately +10%/-5%

54 Ohms

48 Ohms

Impedance
variation on Cal
structures

Weave effect?

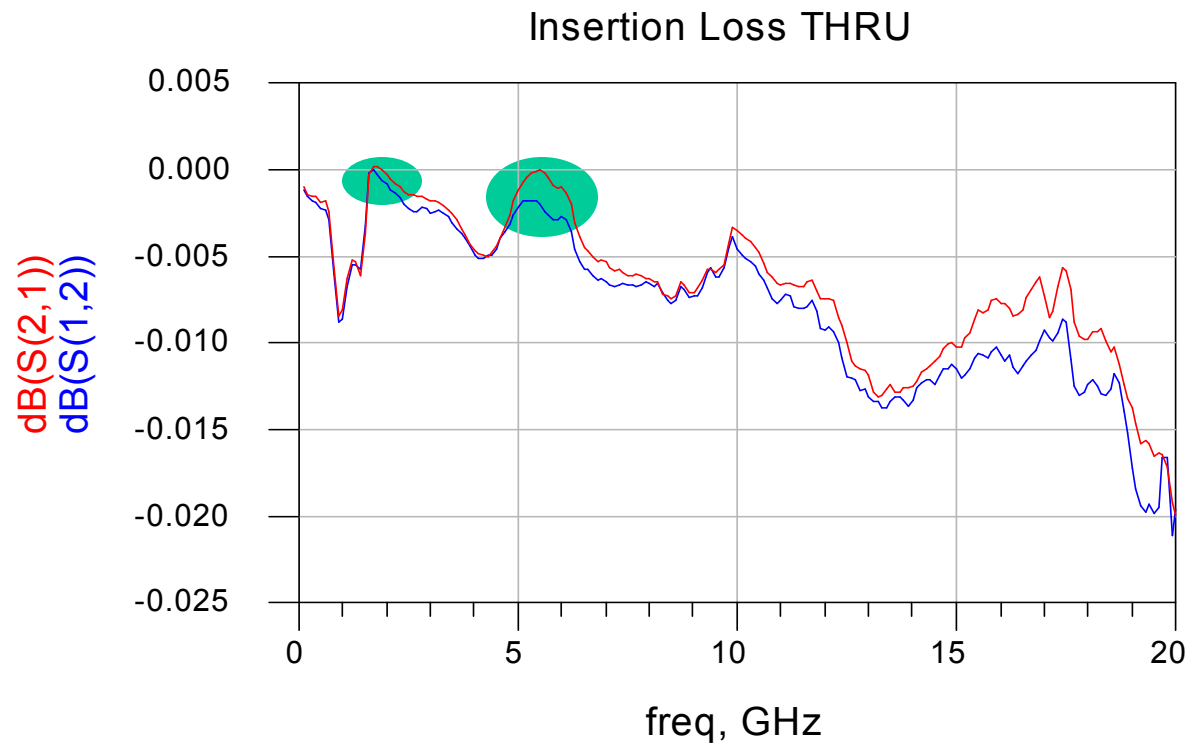


We Encountered Recurring Issues!

- Small passivity issues
 - $<0.05\text{dB}$ in most cases
- Causality issues
 - Anywhere in the frequency band
 - Usually in small areas
 - Noise related
 - Most fixed with averaging or smoothing
 - Improved through decimation



Small Passivity issues



THRU should have
0dB of magnitude
loss, **0dB** of phase,
0psec of **Group Delay**



What are some of the variables

- VNA setup
 - Number of averages
 - IF bandwidth
- Cables
- Connection repeatability
- Standard's quality



Averaging

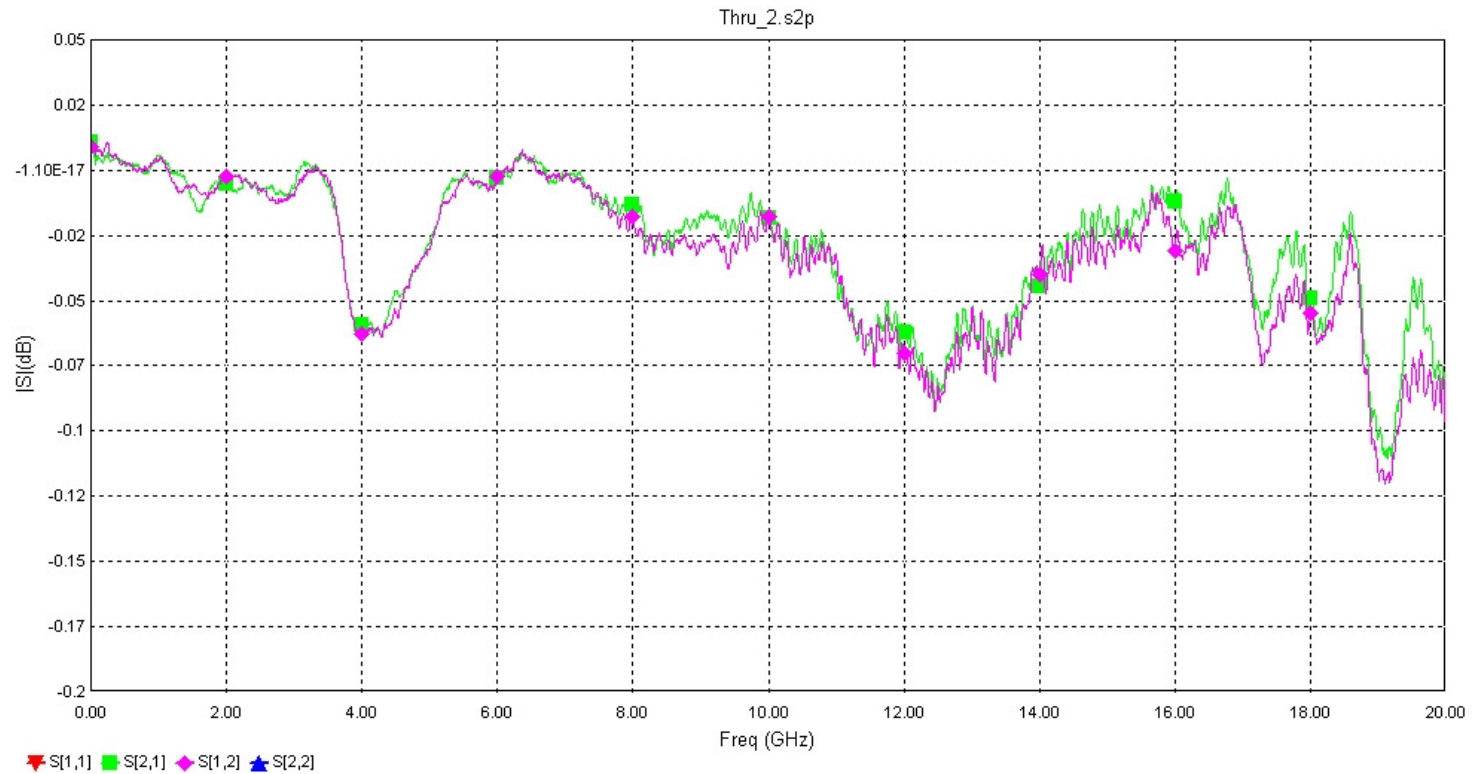
- Averaging improves SNR by \sqrt{N}
 - 100 averages → 20dB improvement



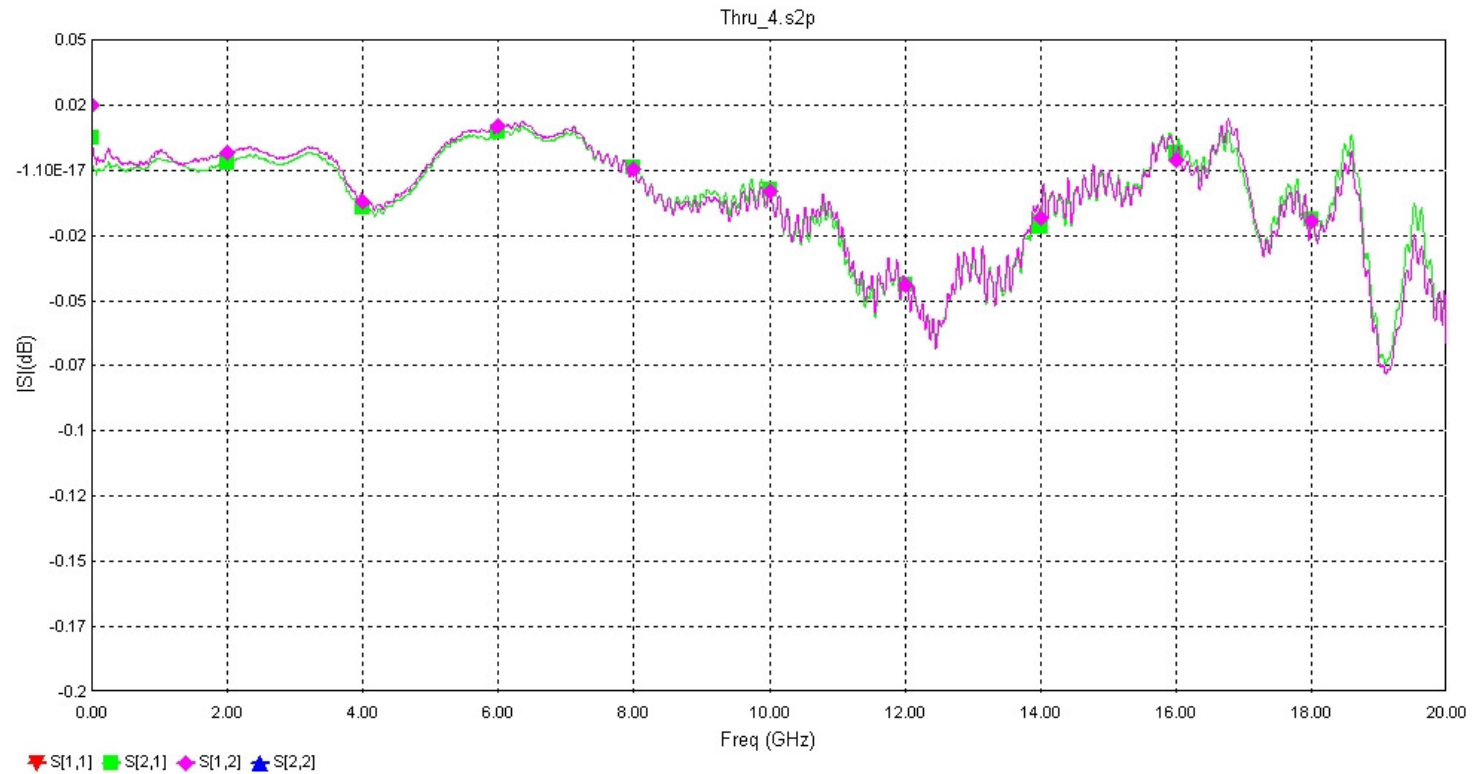
IF bandwidth

- Reduces noise at expense of measurement time
- Original work at 100 KHz
- Experiment at 1 KHz

THRU no AVG 100KHz



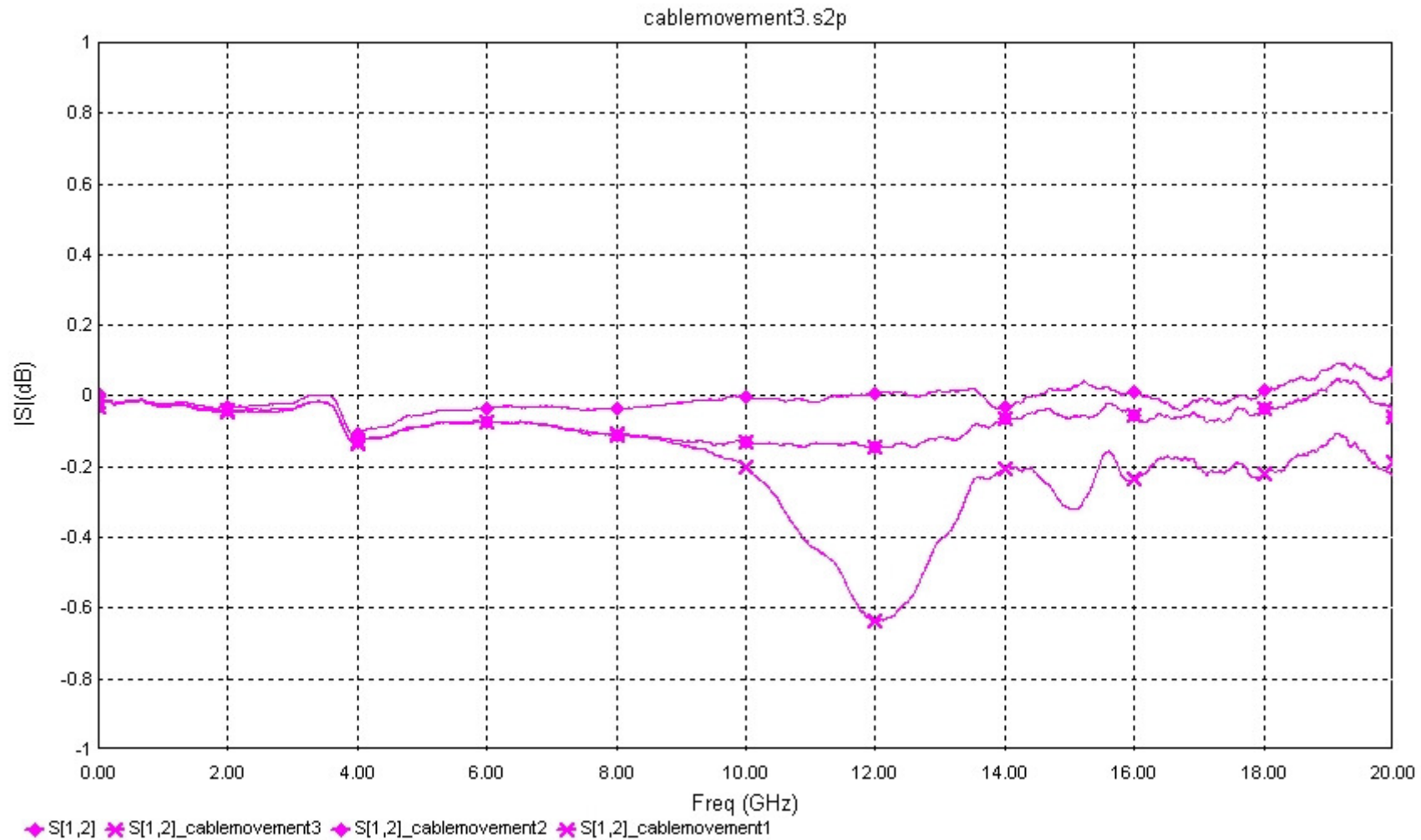
THRU 8AVG 1KHz



Cables

- Cables vary in phase and loss with flexure
 - Did notice we could tune the response
 - Questions about connector to board contact resistance vs stress on connector

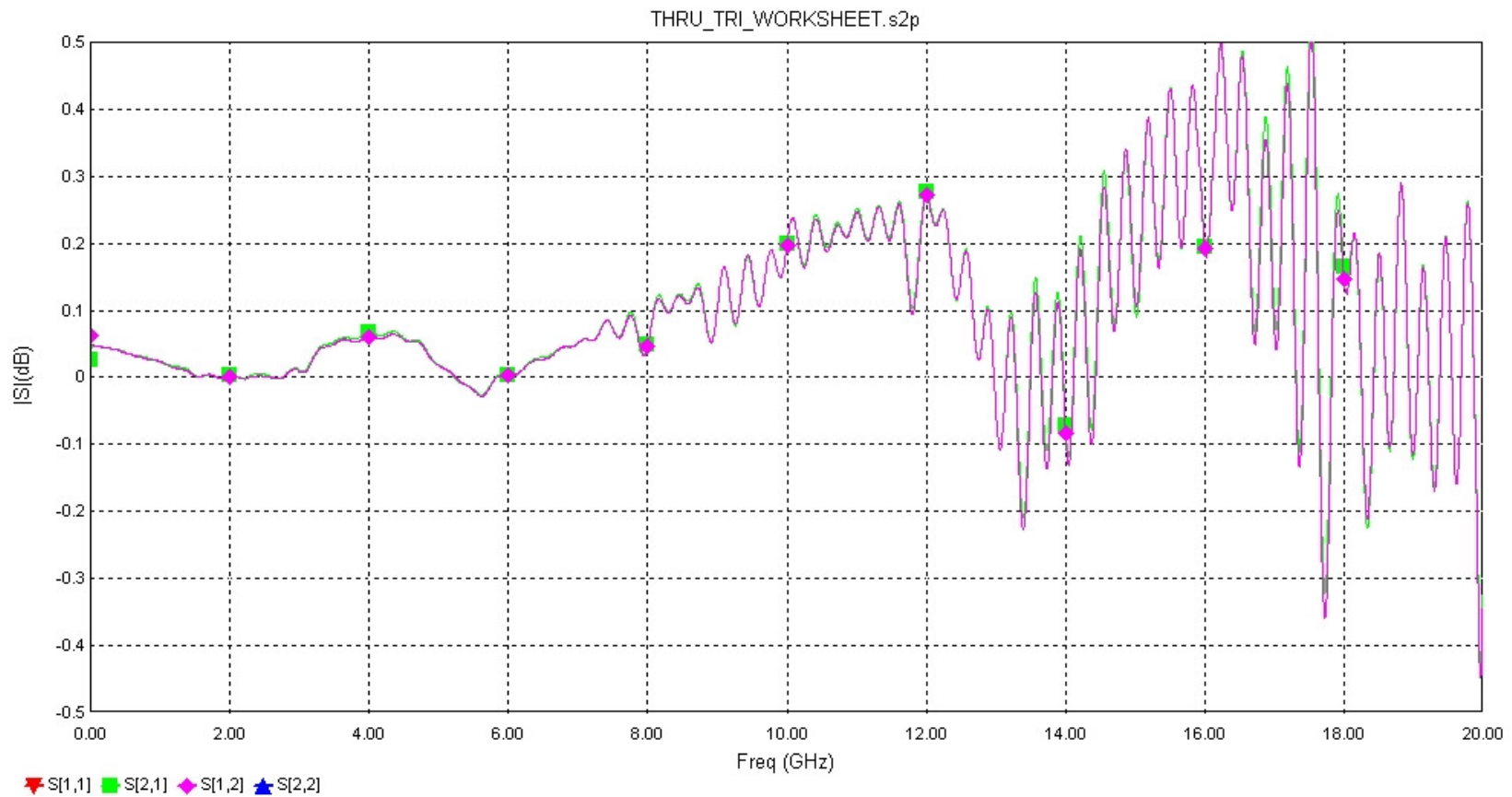
Cable Movement



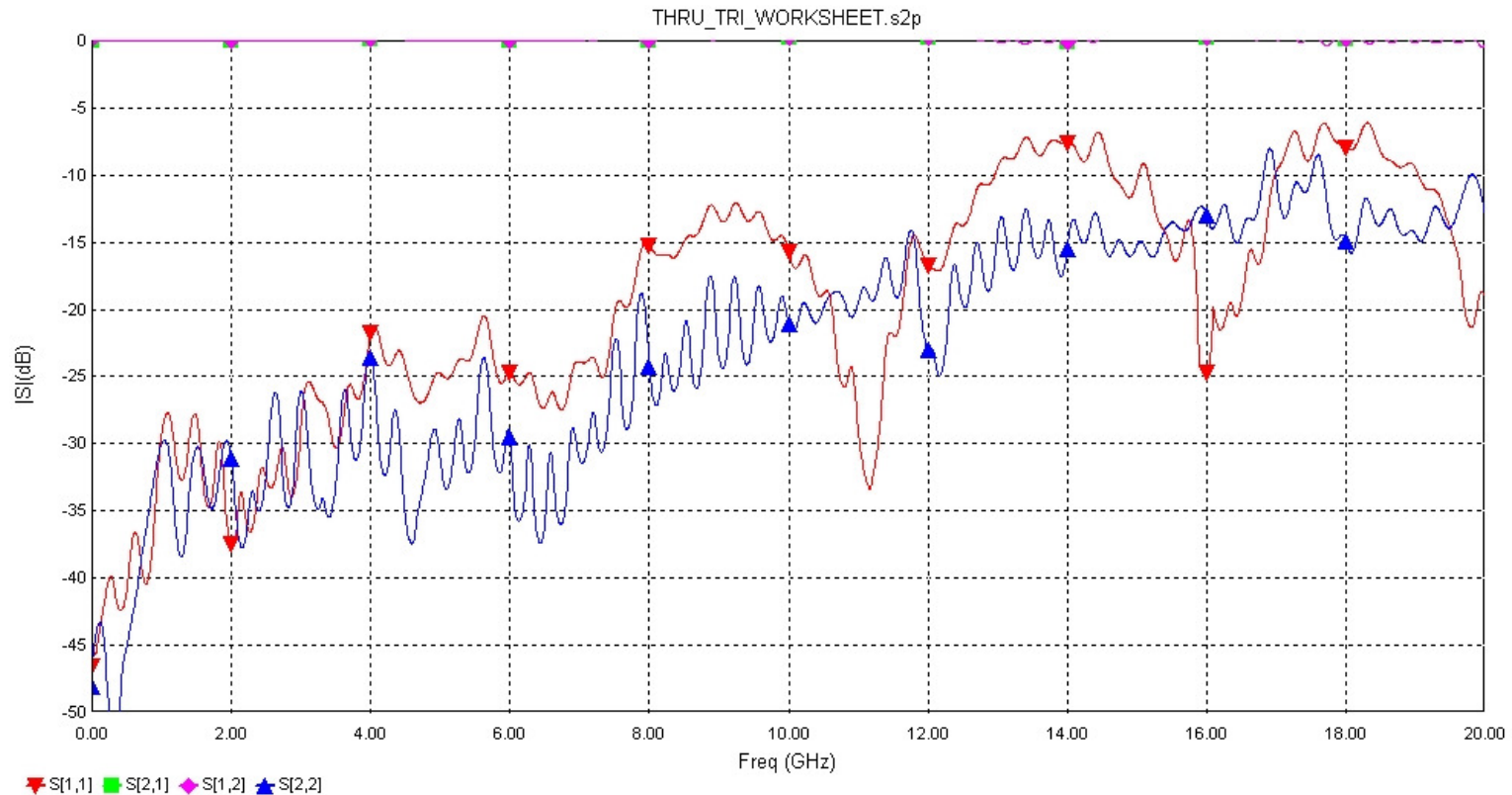
Connector Repeatability

- A requirement for any VNA calibration is consistent measurements
- Connection repeatability is important

Effects of a bad connector - S2I



Effects of a bad connector - S11

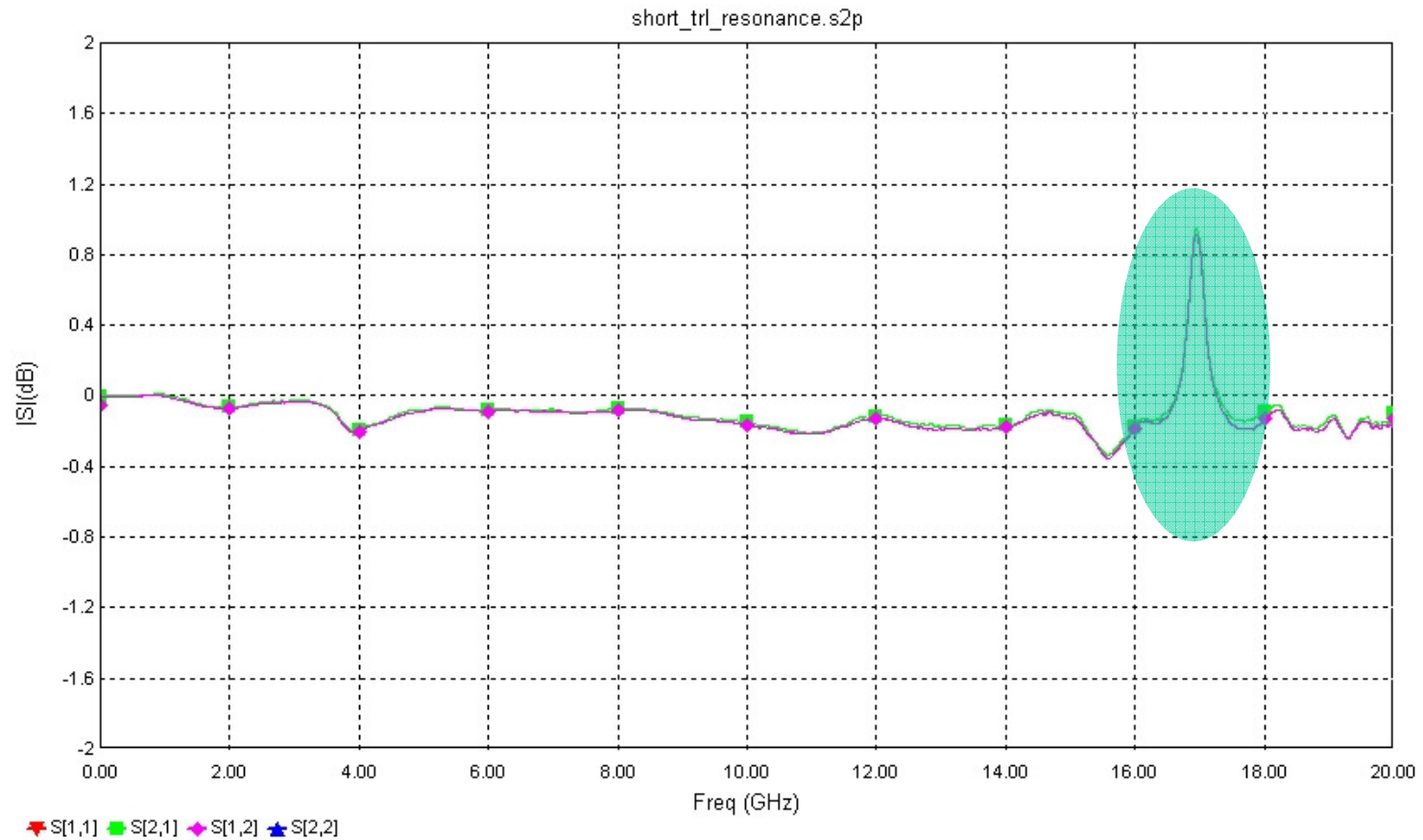


Standard's Quality

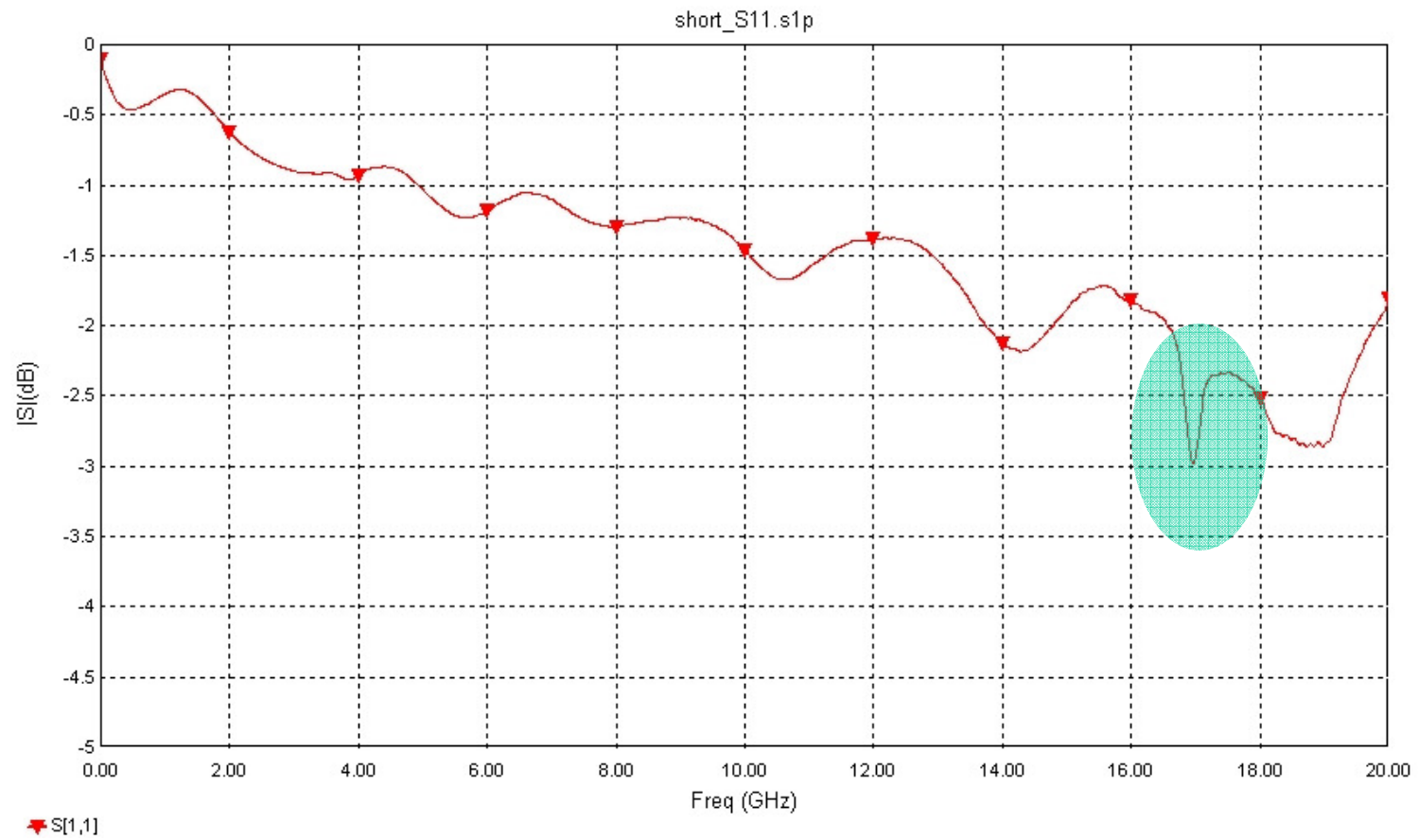
- TRL
 - Transmission or THRU
 - Reflect
 - Open
 - Short
 - Line/Load
- We had an issue with a short



THRU Response After Cal



SII Issue



Conclusions

“After calibration we would like to be able to use measurements as a model”

However, in the “Real World” :

- Calibration does not guarantee causality or passivity for passive structures
- Analysis of data quality is required to improve the accuracy of test fixture removal
- This is not easy stuff – broad band measurements are tough

Thank You

- Tom Dagostino
 - tom@teraspeed.com
 - 503-430-1065

